Se	arch	Not	es

Applicati n/Contr I No.	Applicant(s)/Pat nt und r R xaminati n	•
09/944,939	DANG ET AL.	
Examiner	Art Unit	•
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	SEARCHED		
Class	Subclass	Date	Examiner
707	3	5/22/2006	вто
707	4	5/22/2006	вто
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
707	3	5/27/2006	вто		
707	4	5/27/2006	Bto		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated search	5/22/2006	вто	
consuted with Jean Corrielus, Primary 7107	5/22/2006	вто	
Inventor search	5/26/2006	BTO -	
IEEE	5/27/2006	вто	
АСМ	5/27/2006	вто	
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